

# Three Level NPC Q2Pack Module

# NXH400N100L4Q2F2SG, NXH400N100L4Q2F2PG

The NXH400N100L4Q2 is a power module containing a I-type neutral point clamped three-level inverter. The integrated field stop trench IGBTs and FRDs provide lower conduction losses and switching losses, enabling designers to achieve high efficiency and superior reliability.

#### **Features**

- Neutral Point Clamped Three-level Inverter Module
- Extreme Efficient Trench with Field Stop Technology
- Low Inductive Layout
- Low Package Height
- Thermistor

### **Typical Applications**

- Solar Inverters
- Energy Storage System
- Uninterruptable Power Supplies Systems

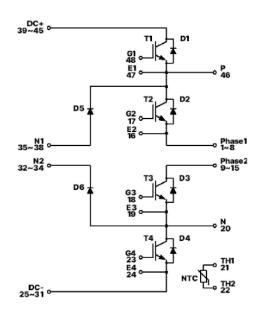
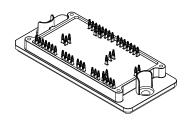
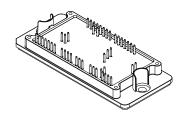


Figure 1. NXH400N100L4Q2F2 Schematic Diagram

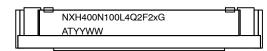


**Q2PACK PRESS FIT PINS** PIM48, 93x47 CASE 180CR



**Q2PACK SOLDER PINS** PIM48, 93x47 CASE 180BL

#### **MARKING DIAGRAM**

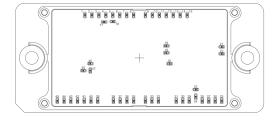


NXH400N100L4Q2F2xG = Specific Device Code

= P or S G

= Pb-Free Package ΑT = Assembly & Test Site Code YYWW = Year and Work Week Code

#### **PIN CONNECTIONS**



#### **ORDERING INFORMATION**

See detailed ordering and shipping information on page 5 of this data sheet.

1

**Table 1. ABSOLUTE MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise noted) (Note 1)

Rating	Symbol	Value	Unit
GBT (T1, T2, T3, T4)	•		•
Collector-Emitter Voltage	V <sub>CES</sub>	1000	V
Gate-Emitter Voltage Positive Transient Gate-Emitter Voltage ( $T_{pulse}$ = 5 $\mu$ s, D < 0.10)	V <sub>GE</sub>	±20 30	V
Continuous Collector Current @ T <sub>C</sub> = 80°C	I <sub>C</sub>	360	А
Pulsed Peak Collector Current @ T <sub>C</sub> = 80°C (T <sub>J</sub> = 175°C)	I <sub>C(Pulse)</sub>	1080	А
Maximum Power Dissipation (T <sub>J</sub> = 175°C)	P <sub>tot</sub>	980	W
Minimum Operating Junction Temperature	T <sub>JMIN</sub>	-40	°C
Maximum Operating Junction Temperature (Note 2)	T <sub>JMAX</sub>	175	°C
GBT INVERSE DIODE (D1, D2, D3, D4)			
Peak Repetitive Reverse Voltage	V <sub>RRM</sub>	1000	V
Continuous Forward Current @ T <sub>C</sub> = 80°C	I <sub>F</sub>	276	А
Repetitive Peak Forward Current (T <sub>J</sub> = 175°C)	I <sub>FRM</sub>	828	А
Maximum Power Dissipation (T <sub>J</sub> = 175°C)	P <sub>tot</sub>	680	W
Minimum Operating Junction Temperature	T <sub>JMIN</sub>	-40	°C
Maximum Operating Junction Temperature	T <sub>JMAX</sub>	175	°C
NEUTRAL POINT DIODE (D5, D6)			
Peak Repetitive Reverse Voltage	V <sub>RRM</sub>	1000	V
Continuous Forward Current @ T <sub>C</sub> = 80°C	I <sub>F</sub>	291	А
Repetitive Peak Forward Current (T <sub>J</sub> = 175°C)	I <sub>FRM</sub>	873	А
Maximum Power Dissipation (T <sub>J</sub> = 175°C)	P <sub>tot</sub>	734	W
Minimum Operating Junction Temperature	T <sub>JMIN</sub>	-40	°C
Maximum Operating Junction Temperature	T <sub>JMAX</sub>	175	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

Table 2. THERMAL AND INSULATION PROPERTIES ( $T_J = 25^{\circ}$ C unless otherwise noted) (Note 1)

( )		, , ,	
Rating	Symbol	Value	Unit
THERMAL PROPERTIES			
Operating Temperature under Switching Condition	T <sub>VJOP</sub>	-40 to 150	°C
Storage Temperature Range	T <sub>stg</sub>	-40 to 125	°C
INSULATION PROPERTIES			
Isolation Test Voltage, t = 1 s, 50 Hz (Note 2)	V <sub>is</sub>	4000	V <sub>RMS</sub>
Creepage Distance		12.7	mm
Comparative Tracking Index	СТІ	>600	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

Refer to <u>ELECTRICAL CHARACTERISTICS</u>, RECOMMENDED OPERATING RANGES and/or APPLICATION INFORMATION for Safe Operating parameters.

<sup>2. 4000</sup> VAČ<sub>RMS</sub> for 1 second duration is equivalent to 3333 VAC<sub>RMS</sub> for 1 minute duration.

**ELECTRICAL CHARACTERISTICS** (T<sub>.I</sub> = 25°C unless otherwise noted)

Characteristic	Symbol	Test Conditions	Min	Тур	Max	Unit
OUTER IGBT (T1, T4) CHARACTERISTI	cs					
Collector-Emitter Cutoff Current	I <sub>CES</sub>	V <sub>GE</sub> = 0 V, V <sub>CE</sub> = 1000 V	-	-	25	μА
Collector-Emitter Saturation Voltage	V <sub>CE(sat)</sub>	V <sub>GE</sub> = 15 V, I <sub>C</sub> = 400 A, T <sub>J</sub> = 25°C	-	1.65	2.2	V
		V <sub>GE</sub> = 15 V, I <sub>C</sub> = 400 A, T <sub>J</sub> = 150°C	-	2.1	-	1
Gate-Emitter Threshold Voltage	V <sub>GE(TH)</sub>	V <sub>GE</sub> = V <sub>CE</sub> , I <sub>C</sub> = 400 mA	3.6	4.9	6.2	٧
Gate Leakage Current	I <sub>GES</sub>	V <sub>GE</sub> = ±20 V, V <sub>CE</sub> = 0 V	-	-	±1.0	μА
Turn-on Delay Time	t <sub>d(on)</sub>	T <sub>J</sub> = 25°C	-	170.46	_	ns
Rise Time	t <sub>r</sub>	$V_{CE} = 600 \text{ V}, I_{C} = 200 \text{ A}$ $V_{GE} = -9 \text{ V}, 15 \text{ V},$	-	54.38	-	1
Turn-off Delay Time	t <sub>d(off)</sub>	$R_{Gon} = 9 \Omega$ , $R_{Goff} = 19 \Omega$	-	696.63	-	1
Fall Time	t <sub>f</sub>	1	-	12.91	-	1
Turn-on Switching Loss per Pulse	E <sub>on</sub>	1	-	8.96	-	mJ
Turn-off Switching Loss per Pulse	E <sub>off</sub>	1	-	6	-	1
Turn-on Delay Time	t <sub>d(on)</sub>	T <sub>J</sub> = 125°C	_	163.09	-	ns
Rise Time	t <sub>r</sub>	$V_{CE} = 600 \text{ V}, I_{C} = 200 \text{ A}$ $V_{GF} = -9 \text{ V}, 15 \text{ V},$	-	61.38	-	1
Turn-off Delay Time	t <sub>d(off)</sub>	$R_{Gon} = 9 \Omega$ , $R_{Goff} = 19 \Omega$	_	771.31	_	1
Fall Time	t <sub>f</sub>	1	-	18.23	-	1
Turn-on Switching Loss per Pulse	E <sub>on</sub>	1	_	14.54	-	mJ
Turn-off Switching Loss per Pulse	E <sub>off</sub>	1	_	9.8	_	1
Input Capacitance	C <sub>ies</sub>	$V_{CE}$ = 20 V, $V_{GE}$ = 0 V, f = 1 MHz		26060	_	pF
Output Capacitance	C <sub>oes</sub>	1	_	1182	_	
Reverse Transfer Capacitance	C <sub>res</sub>	1	-	146	=	]
Total Gate Charge	$Q_g$	$V_{CE} = 600 \text{ V}, I_{C} = 300 \text{ A},$ $V_{GE} = -15 \text{ V} \sim 15 \text{ V}$	-	1410	-	nC
Thermal Resistance - Chip-to-Heatsink	R <sub>thJH</sub>	Thermal grease,	-	0.17	-	K/W
Thermal Resistance - Chip-to-Case	R <sub>thJC</sub>	Thickness = 100 $\mu$ m ±2% $\lambda$ = 2.9 W/mK	-	0.0969	-	K/W
NEUTRAL POINT DIODE (D5, D6) CHAF	ACTERISTIC	cs	ı			
Diode Forward Voltage	V <sub>F</sub>	I <sub>F</sub> = 225 A, T <sub>J</sub> = 25°C	_	2.1	2.7	V
-		I <sub>F</sub> = 225 A, T <sub>J</sub> = 150°C	-	1.9	-	1
Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> = 25°C	-	91.65	-	ns
Reverse Recovery Charge	Q <sub>rr</sub>	$V_{CE} = 600 \text{ V, } I_{C} = 200 \text{ A}$ $V_{GE} = -9 \text{ V, } 15 \text{ V, } R_{G} = 9 \Omega$	_	5109	_	nC
Peak Reverse Recovery Current	I <sub>RRM</sub>	VGE - 0 V, 10 V, 11G - 0 32	-	117.19	_	Α
Peak Rate of Fall of Recovery Current	di/dt		-	3.02	-	A/ns
Reverse Recovery Energy	E <sub>rr</sub>	1	-	1504	-	μJ
Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> = 125°C	-	168.8	_	ns
Reverse Recovery Charge	Q <sub>rr</sub>	$V_{CE} = 600 \text{ V, } I_{C} = 200 \text{ A}$ $V_{GE} = -9 \text{ V, } 15 \text{ V, } R_{G} = 9 \Omega$	-	15979	_	nC
Peak Reverse Recovery Current	I <sub>RRM</sub>	- GC 5 1, 10 1, 11G - 0 11	-	183.14	_	Α
Peak Rate of Fall of Recovery Current	di/dt		-	2.64	-	A/ns
Reverse Recovery Energy	E <sub>rr</sub>	†	_	5463	_	μJ
Thermal Resistance - Chip-to-Heatsink	R <sub>thJH</sub>	Thermal grease,	-	0.21	_	K/W
Thermal Resistance – Chip-to-Case	R <sub>thJC</sub>	Thickness = 100 $\mu$ m ±2% $\lambda$ = 2.9 W/mK	_	0.1295	_	K/W

**ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise noted) (continued)

Characteristic	Symbol	Test Conditions	Min	Тур	Max	Unit
INNER IGBT (T2, T3) CHARACTERISTIC	S					
Collector-Emitter Cutoff Current	I <sub>CES</sub>	V <sub>GE</sub> = 0 V, V <sub>CE</sub> = 1000 V	-	-	25	μΑ
Collector-Emitter Saturation Voltage	V <sub>CE(sat)</sub>	V <sub>GE</sub> = 15 V, I <sub>C</sub> = 400 A, T <sub>J</sub> = 25 °C	-	1.65	2.2	V
		V <sub>GE</sub> = 15 V, I <sub>C</sub> = 400 A, T <sub>J</sub> = 150 °C	-	1.9	-	1
Gate-Emitter Threshold Voltage	V <sub>GE(TH)</sub>	$V_{GE} = V_{CE}$ , $I_C = 400$ mA	3.9	4.6	5.8	V
Gate Leakage Current	I <sub>GES</sub>	V <sub>GE</sub> = ±20 V, V <sub>CE</sub> = 0 V	-	-	±1.0	μΑ
Turn-on Delay Time	t <sub>d(on)</sub>	T <sub>J</sub> = 25°C	ı	171.27	-	ns
Rise Time	t <sub>r</sub>	$V_{CE} = 600 \text{ V, } I_{C} = 200 \text{ A,}$ $V_{GE} = -9 \text{ V, } 15 \text{ V,}$	ı	52.54	ı	
Turn-off Delay Time	t <sub>d(off)</sub>	$R_{Gon} = 9 \Omega$ , $R_{Goff} = 28 \Omega$	ı	1153.7	-	]
Fall Time	t <sub>f</sub>		-	34.88	-	
Turn-on Switching Loss per Pulse	E <sub>on</sub>		ı	8.16	ı	mJ
Turn off Switching Loss per Pulse	E <sub>off</sub>		ı	10.25	ı	
Turn-on Delay Time	t <sub>d(on)</sub>	T <sub>J</sub> = 125°C	-	160.21	-	ns
Rise Time	t <sub>r</sub>	$V_{CE} = 600 \text{ V}, I_{C} = 200 \text{ A},$ $V_{GE} = -9 \text{ V}, 15 \text{ V},$	-	59.83	-	
Turn-off Delay Time	t <sub>d(off)</sub>	$R_{Gon} = 9 \Omega, R_{Goff} = 28 \Omega$	-	1274.8	-	
Fall Time	t <sub>f</sub>	_	-	26.46	-	
Turn-on Switching Loss per Pulse	E <sub>on</sub>	₫	ı	12.37	-	mJ
Turn off Switching Loss per Pulse	E <sub>off</sub>		ı	13.42	-	
Input Capacitance	C <sub>ies</sub>	$V_{CE} = 20 \text{ V}, V_{GE} = 0 \text{ V}, f = 1 \text{ MHz}$	ı	26060	-	pF
Output Capacitance	C <sub>oes</sub>		-	1182	-	4
Reverse Transfer Capacitance	C <sub>res</sub>		ı	146	-	
Total Gate Charge	$Q_g$	$V_{CE} = 600 \text{ V}, I_{C} = 300 \text{ A}, V_{GE} = -15 \text{ V} \sim 15 \text{ V}$	_	1410	-	nC
Thermal Resistance - Chip-to-heatsink	R <sub>thJH</sub>	Thermal grease, Thickness = 100 μm ±2%	ı	0.17	-	K/W
Thermal Resistance - Chip-to-case	$R_{thJC}$	thJC $\lambda = 2.9 \text{ W/mK}$		0.0969	-	K/W
IGBT INVERSE DIODE (D1, D2, D3, D4)	CHARACTE	RISTICS				
Diode Forward Voltage	V <sub>F</sub>	I <sub>F</sub> = 225 A, T <sub>J</sub> = 25°C	-	2.1	2.7	V
		I <sub>F</sub> = 225 A, T <sub>J</sub> = 150°C	_	1.9	_	1
Reverse Recovery Time	t <sub>rr</sub>	$T_J = 25^{\circ}C$	_	90.31	-	ns
Reverse Recovery Charge	Q <sub>rr</sub>	$V_{CE} = 600 \text{ V}, I_{C} = 200 \text{ A}$ $V_{GE} = -9 \text{ V}, 15 \text{ V}, R_{G} = 9 \Omega$	-	5653	-	nC
Peak Reverse Recovery Current	I <sub>RRM</sub>	]	ı	123.4	1	Α
Peak Rate of Fall of Recovery Current	di/dt		-	3.178	-	A/ns
Reverse Recovery Energy	E <sub>rr</sub>		_	1860	-	μJ
Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> = 125°C	-	167.18	-	ns
Reverse Recovery Charge	Q <sub>rr</sub>	$V_{CE} = 600 \text{ V}, I_{C} = 200 \text{ A}$ $V_{GF} = -9 \text{ V}, 15 \text{ V}, R_{G} = 9 \Omega$	1	16627	-	nC
Peak Reverse Recovery Current	I <sub>RRM</sub>	- 'GE - ', ' - ', ' · G	1	182.8	-	Α
Peak Rate of Fall of Recovery Current	di/dt		_	2.734	-	A/ns
Reverse Recovery Energy	E <sub>rr</sub>	1	_	6512	-	μJ
Thermal Resistance - Chip-to-Heatsink	R <sub>thJH</sub>	Thermal grease,	_	0.22	-	K/W
Thermal Resistance - Chip-to-Case	R <sub>thJC</sub>	Thickness = 100 $\mu$ m ±2% $\lambda$ = 2.9 W/mK	-	0.1397	-	K/W
THERMISTOR CHARACTERISTICS						
Nominal Resistance	R <sub>25</sub>	T = 25°C	-	5	-	kΩ
Nominal Resistance	R <sub>100</sub>	T = 100°C	1	490.6	-	Ω

### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise noted) (continued)

Characteristic	Symbol	Test Conditions	Min	Тур	Max	Unit
THERMISTOR CHARACTERISTICS						
Deviation of R25	ΔR/R		-1	-	1	%
Power Dissipation	$P_{D}$		-	5	-	mW
Power Dissipation Constant			-	1.3	-	mW/K
B-value		B (25/85), tolerance ±1%	-	3435	-	K

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

#### **ORDERING INFORMATION**

Part Number	Marking	Package	Shipping
NXH400N100L4Q2F2PG	NXH400N100L4Q2F2PG	Q2PACK PRESS FIT PINS PIM48, 93x47 (Pb-Free and Halide-Free)	12 Units / Blister Tray
NXH400N100L4Q2F2SG	NXH400N100L4Q2F2SG	Q2PACK SOLDER PIN PIM48, 93x47 (Pb-Free and Halide-Free)	12 Units / Blister Tray

#### TYPICAL CHARACTERISTICS - IGBT, INVERSE DIODE AND NEUTRAL POINT DIODE

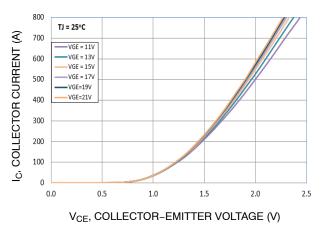
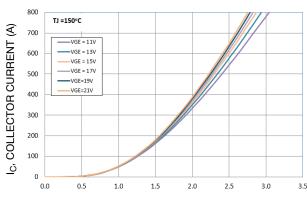
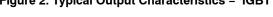


Figure 2. Typical Output Characteristics - IGBT



V<sub>CE</sub>, COLLECTOR-EMITTER VOLTAGE (V)

Figure 3. Typical Output Characteristics – IGBT



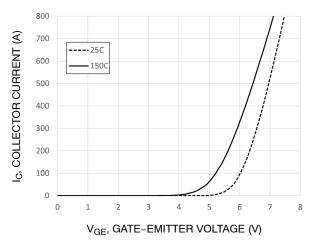


Figure 4. Transfer Characteristics - IGBT

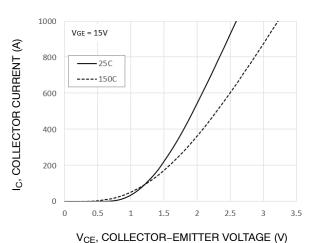


Figure 5. Saturation Voltage Characteristics

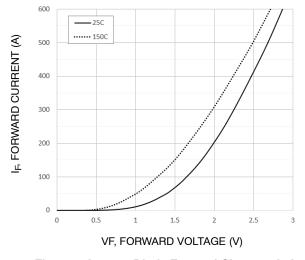


Figure 6. Inverse Diode Forward Characteristics

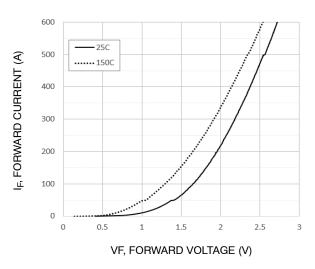


Figure 7. Buck Diode Forward Characteristics

#### TYPICAL CHARACTERISTICS - OUTER IGBT (T1, T4)

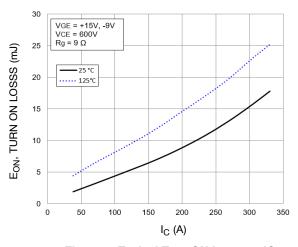


Figure 8. Typical Turn ON Loss vs. IC

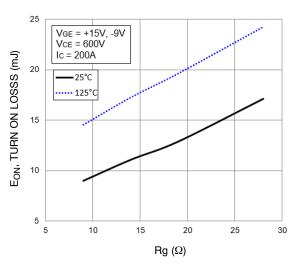


Figure 10. Typical Turn ON Loss vs. RG

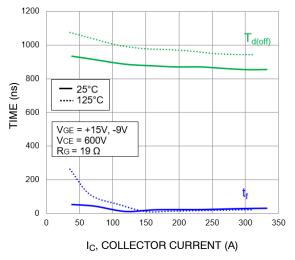


Figure 12. Typical Turn-Off Switching Time vs. IC

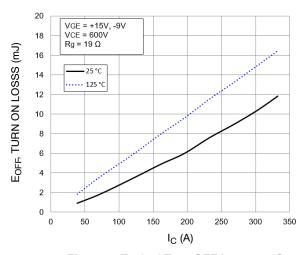


Figure 9. Typical Turn OFF Loss vs. IC

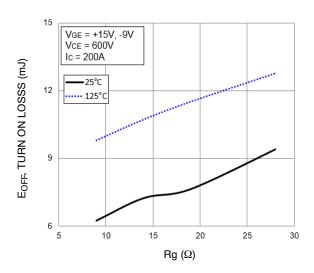


Figure 11. Typical Turn OFF Loss vs. RG

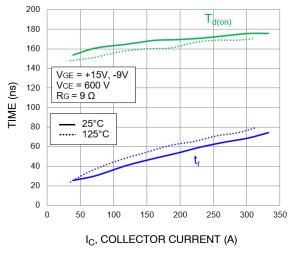


Figure 13. Typical Turn-On Switching Time vs. IC

### TYPICAL CHARACTERISTICS - OUTER IGBT (T1,T4) (continued)

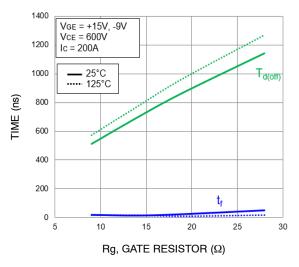


Figure 14. Typical Turn-Off Switching Time vs. RG

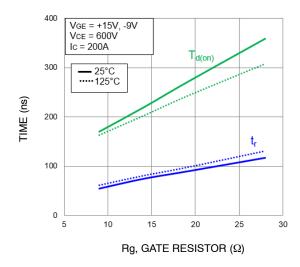


Figure 15. Typical Turn-On Switching Time vs. RG

#### TYPICAL CHARACTERISTICS - INNER IGBT (T2, T3)

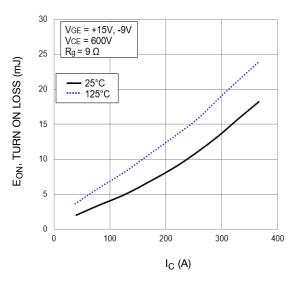


Figure 16. Typical Turn ON Loss vs. IC

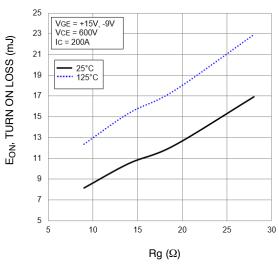


Figure 18. Typical Turn ON Loss vs. RG

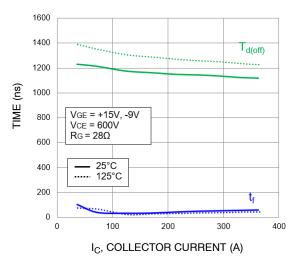


Figure 20. Typical Turn-Off Switching Time vs. IC

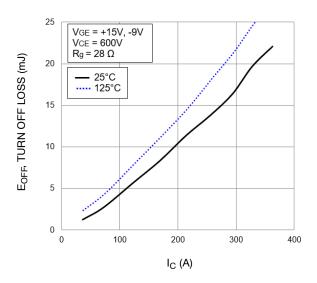


Figure 17. Typical Turn OFF Loss vs. IC

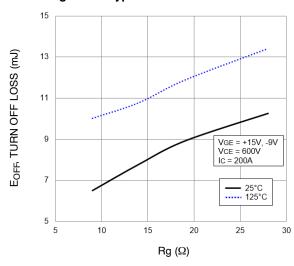


Figure 19. Typical Turn OFF Loss vs. RG

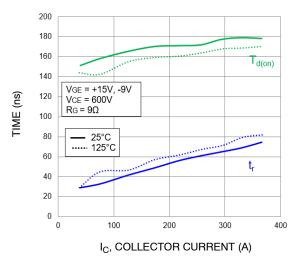
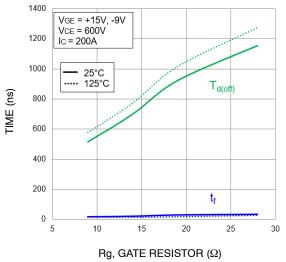


Figure 21. Typical Turn-On Switching Time vs. IC

### TYPICAL CHARACTERISTICS - INNER IGBT (T2, T3) (continued)





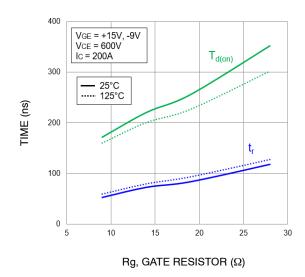


Figure 23. Typical Turn-On Switching Time vs. RG

#### TYPICAL SWITCHING CHARACTERISTICS - NEUTRAL POINT DIODE

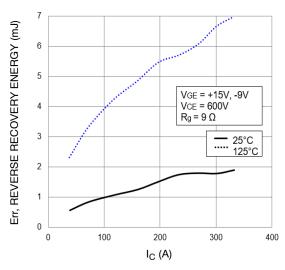


Figure 24. Typical Reverse Recovery Energy Loss vs. IC

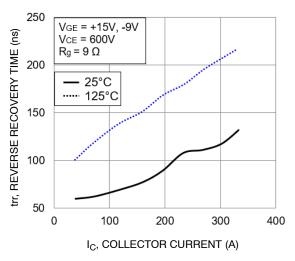


Figure 26. Typical Reverse Recovery Time vs. IC

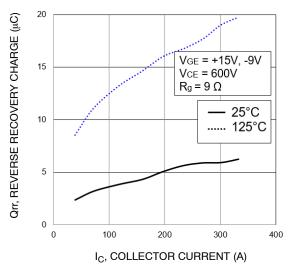


Figure 28. Typical Reverse Recovery Charge vs. IC

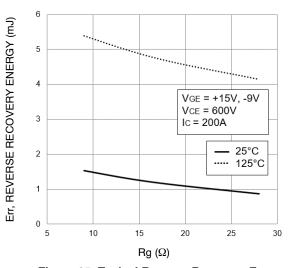


Figure 25. Typical Reverse Recovery Energy Loss vs. Rg

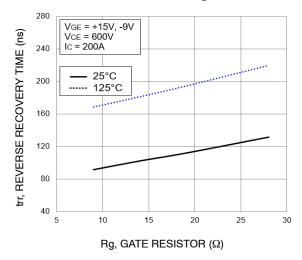


Figure 27. Typical Reverse Recovery Time vs. Rg

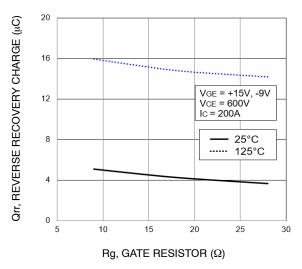


Figure 29. Typical Reverse Recovery Charge vs. Rg

#### TYPICAL SWITCHING CHARACTERISTICS - NEUTRAL POINT DIODE (continued)

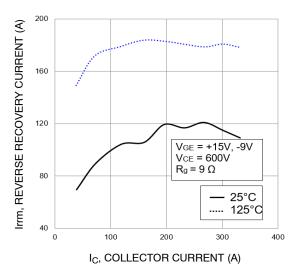


Figure 30. Typical Reverse Recovery Peak Current vs. IC

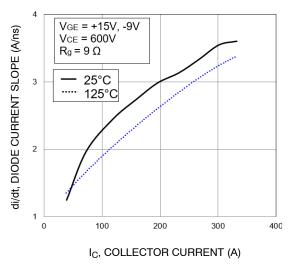


Figure 32. Typical di/dt vs. IC

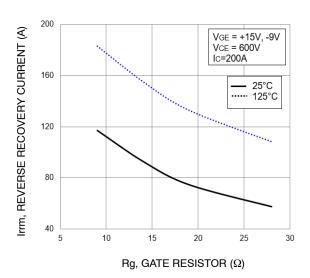


Figure 31. Typical Reverse Recovery Peak Current vs. Rg

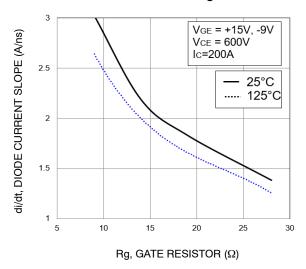


Figure 33. Typical di/dt vs. Rg

#### **TYPICAL CHARACTERISTICS - INVERSE DIODE**

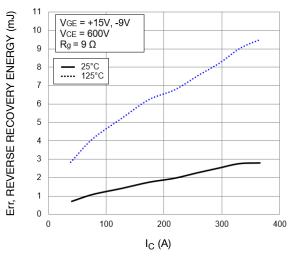


Figure 34. Typical Reverse Recovery Energy Loss vs. IC

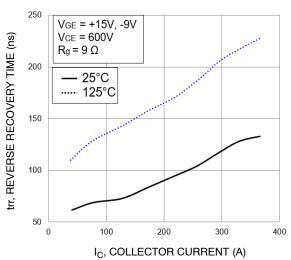


Figure 36. Typical Reverse Recovery Time vs. IC

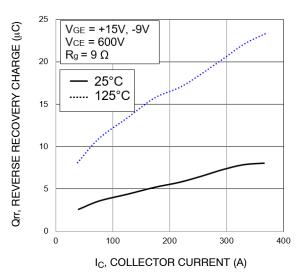


Figure 38. Typical Reverse Recovery Charge vs. IC

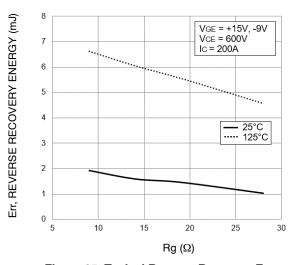


Figure 35. Typical Reverse Recovery Energy Loss vs. Rg

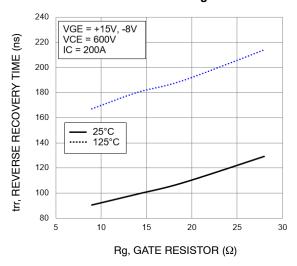


Figure 37. Typical Reverse Recovery Time vs. Rg

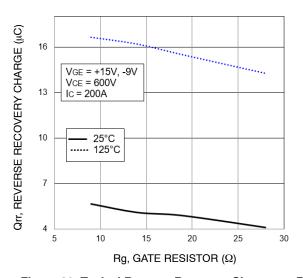


Figure 39. Typical Reverse Recovery Charge vs. Rg

#### TYPICAL CHARACTERISTICS - INVERSE DIODE (continued)

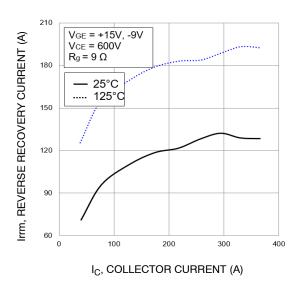


Figure 40. Typical Reverse Recovery Peak Current vs. IC

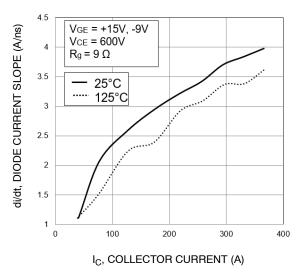


Figure 42. Typical di/dt vs. IC

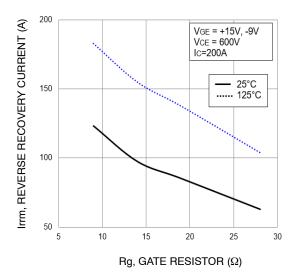


Figure 41. Typical Reverse Recovery Peak Current vs. Rg

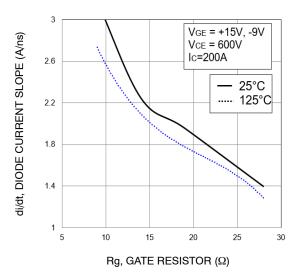
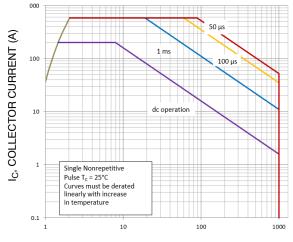


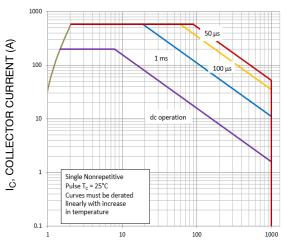
Figure 43. Typical di/dt vs. Rg

#### TYPICAL CHARACTERISTICS - IGBT, INVERSE DIODE AND NEUTRAL POINT DIODE



V<sub>CE</sub>, COLLECTOR-EMITTER VOLTAGE (V)

Figure 44. FBSOA - Outer IGBT



V<sub>CE</sub>, COLLECTOR-EMITTER VOLTAGE (V)

Figure 46. FBSOA - Inner IGBT

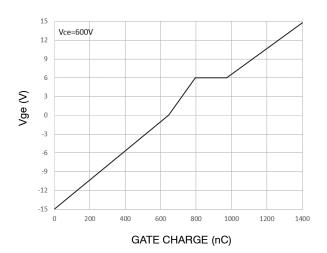
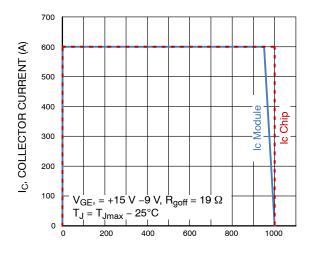
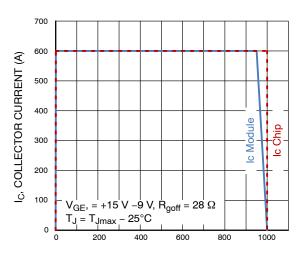


Figure 48. Gate Voltage vs. Gate Charge



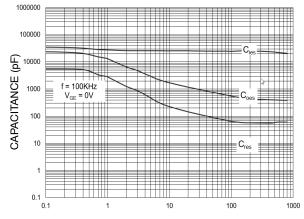
V<sub>CE</sub>, COLLECTOR-EMITTER VOLTAGE (V)

Figure 45. RBSOA – Outer IGBT



V<sub>CE</sub>, COLLECTOR-EMITTER VOLTAGE (V)

Figure 47. RBSOA - Inner IGBT



V<sub>CE</sub>, COLLECTOR TO EMITTER VOLTAGE (V)

Figure 49. Capacitance Charge

### TYPICAL CHARACTERISTICS - IGBT, INVERSE DIODE AND NEUTRAL POINT DIODE (continued)

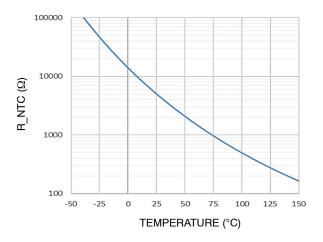


Figure 50. Thermistor Characteristics

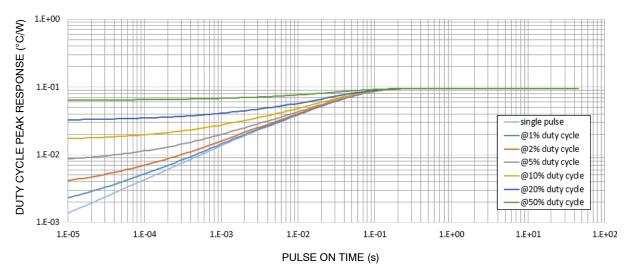


Figure 51. Transient Thermal Impedance - IGBT

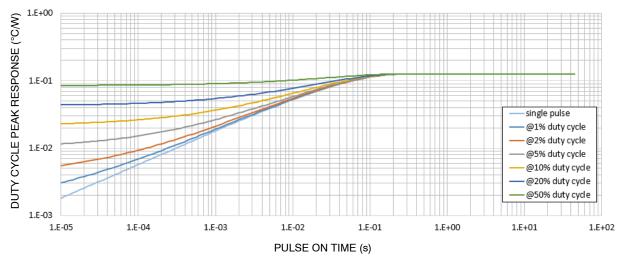


Figure 52. Transient Thermal Impedance - Inverse Diode

### TYPICAL CHARACTERISTICS - IGBT, INVERSE DIODE AND NEUTRAL POINT DIODE (continued)

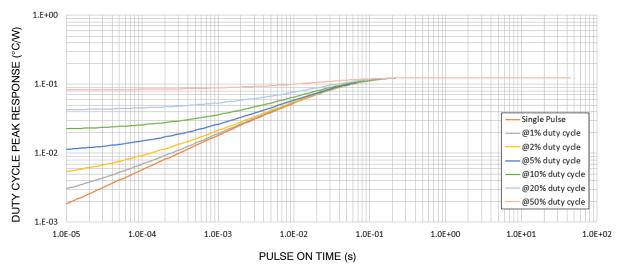


Figure 53. Transient Thermal Impedance - Neutral Point Diode

**DATE 08 DEC 2022** 

MILLIMETERS

NOM.

17.20

12.00

4.70

16.70

1.00

93.00

104.75

82.00

107.20

47.00

44.40

39.00

5.50

10.70

2.00

MAX.

17.60

12.30

5.00

17.00

1.05

93.10

105.05

82.20

107.50

47.30

44.70

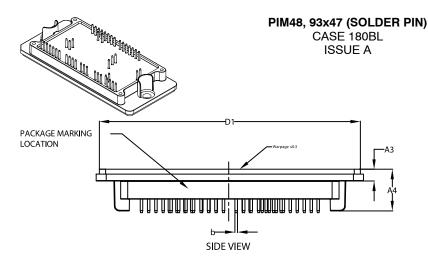
39.20

5.60

10.80

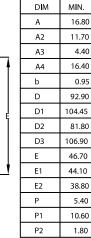
2.20

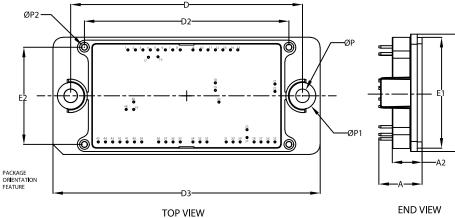




#### NOTES

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. DIMENSIONS 6 AND 61 APPLY TO THE PLATED TERMINALS AND ARE MEASURED AT DIMENSION A1
- 4. PIN POSITION TOLERANCE IS ± 0.4mm
- 5. PACKAGE MARKING IS LOCATED AS SHOWN ON THE SIDE OPPOSITE THE PACKAGE ORIENTATION FEATURES





#### **S** Pin position

Pin table		Pin table					
Pin	х	Υ	Function	Pin	Х	Υ	Function
1	11.9	36.9	Phase1	25	70.9	0	DC-
2	14.9	36.9	Phase1	26	68.1	0	DC-
3	17.9	36.9	Phase1	27	65.3	0	DC-
4	20.9	36.9	Phase1	28	62.5	0	DC-
5	23.9	36.9	Phase1	29	56.9	0	DC-
6	26.9	36.9	Phase1	30	54.1	0	DC-
7	29.9	36.9	Phase1	31	51.3	0	DC-
8	32.9	36.9	Phase1	32	43.6	0	N2
9	38	36.9	Phase2	33	40.8	0	N2
10	41	36.9	Phase2	34	38	0	N2
11	44	36.9	Phase2	35	32.9	0	N1
12	47	36.9	Phase2	36	30	0	N1
13	50	36.9	Phase2	37	27.1	0	N1
14	53	36.9	Phase2	38	24.2	0	N1
15	56	36.9	Phase2	39	17.4	0	DC+
16	23.95	34.1	E2	40	14.5	0	DC+
17	20.15	33.9	G2	41	11.6	0	DC+
18	47	23.65	G3	42	8.7	0	DC+
19	47	20.65	E3	43	5.8	0	DC+
20	48.4	15.95	N	44	2.9	0	DC+
21	70.9	23.2	TH1	45	0	0	DC+
22	70.9	20.2	TH2	46	14.2	16	Р
23	59.7	4.85	G4	47	14.2	13	E1
24	59.7	1.75	E4	48	11.2	13	G1

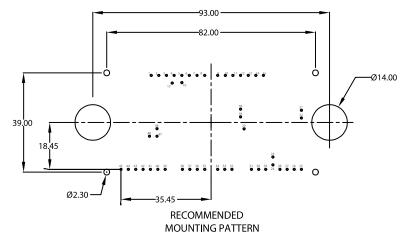
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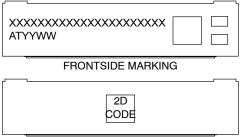
CASE 180BL ISSUE A

**DATE 08 DEC 2022** 



\* For additional Information on our Pb—Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

# GENERIC MARKING DIAGRAM\*



BACKSIDE MARKING

XXXXX = Specific Device Code
AT = Assembly & Test Site Code
YYWW = Year and Work Week Code

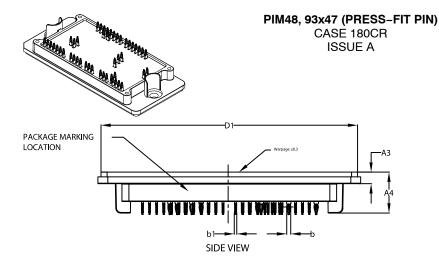
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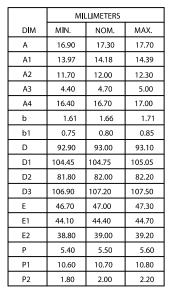
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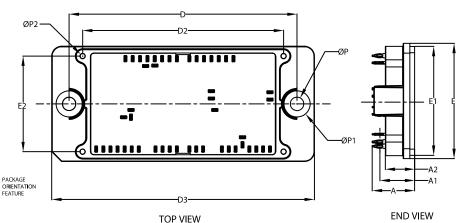




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19	47	20.65	E3	43	5.8	0	DC+
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21	70.9	23.2	TH1	45	0	0	DC+
22	70.9	20.2	TH2	46	14.2	16	Р
23	59.7	4.85	G4	47	14.2	13	E1
24	59.7	1.75	E4	48	11.2	13	G1

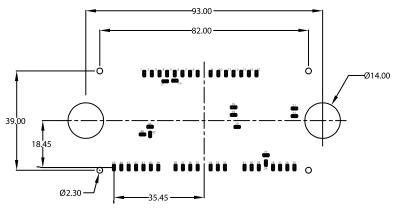
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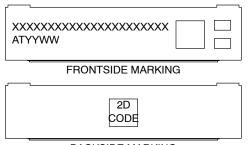
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# RECOMMENDED MOUNTING PATTERN

\* For additional Information on our Pb—Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

# GENERIC MARKING DIAGRAM\*



BACKSIDE MARKING

XXXXX = Specific Device Code
AT = Assembly & Test Site Code
YYWW = Year and Work Week Code

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

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